

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of:

AKRAM ALI SALMAN XUEJUN ZHAO KURT O. TAYLOR STEPHEN G. BEEBE

Serial No.: 10/664,665

Filed: September 18, 2003

For: METHOD FOR DETERMINING THE

RELIABILITY OF DIELECTRIC

LAYERS

Commissioner for Patents

Alexandria, VA 22313-1450

Mail Stop AF

P.O. Box 1450

Examiner: Laura M. Schillinger

Group Art Unit: 2813

Att'y Docket: 2000.111200/H2022

Customer No.: 23720

RESPONSE TO FINAL OFFICE ACTION DATED JULY 12, 2005

CERTIFICATE OF MAILING 37 C.F.R 1.8

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the date below:

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September 12, 2005 Date

Sir:

This paper is submitted in response to the Final Office Action dated July 12, 2005, for which the three-month date for response is October 12, 2005.

No fees are believed to be due in connection with the present paper. However, should any fees be required under 37 C.F.R. §§ 1.16 to 1.21, the Director is authorized to deduct such fees from the Advanced Micro Devices, Inc. Deposit Account No. 01-0365/H2022. In the event the monies in that account are insufficient, the Director is authorized to withdraw funds from Williams, Morgan & Amerson, P.C. Deposit Account No. 50-0786/2000.111200.

Reconsideration of the application in view of the following amendments and remarks is respectfully requested.